



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

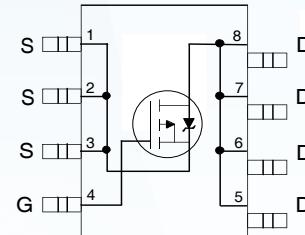
## Product Specification

▶ Domestic Part Number	IRF7416
▶ Overseas Part Number	IRF7416
▶ Equivalent Part Number	IRF7416



**P-Channel 30 V (D-S) MOSFET**
**FEATURES**

- Low On-Resistance
- P-Channel Mosfet
- Surface Mount
- dv/dt Rating
- Fast Switching



Top View

**Absolute Maximum Ratings**

	Parameter	Max.	Units
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -10\text{V}$	-10	A
$I_D @ T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -10\text{V}$	-7.1	
$I_{DM}$	Pulsed Drain Current ①	-45	
$P_D @ T_A = 25^\circ\text{C}$	Power Dissipation	2.5	W
	Linear Derating Factor	0.02	$\text{W}/^\circ\text{C}$
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	370	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	-5.0	$\text{V}/\text{ns}$
$T_J$	Operating Junction and		
$T_{STG}$	Storage Temperature Range	-55 to + 150	$^\circ\text{C}$

**Thermal Resistance**

	Parameter	Max.	Units
$R_{\text{JA}}$	Junction-to-Ambient ⑤	50	$^\circ\text{C}/\text{W}$

**Static Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

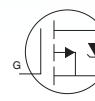
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})DSS}$	Drain-to-Source Breakdown Voltage	-30	—	—	V	$V_{GS} = 0\text{V}$ , $I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.024	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = -1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	20	$\text{m}\Omega$	$V_{GS} = -10\text{V}$ , $I_D = -5.6\text{A}$ ④
		—	—	35		$V_{GS} = -4.5\text{V}$ , $I_D = -2.8\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	-1.0	—	-2.04	V	$V_{DS} = V_{GS}$ , $I_D = -250\mu\text{A}$
$g_{fs}$	Forward Transconductance	5.6	—	—	S	$V_{DS} = -10\text{V}$ , $I_D = -2.8\text{A}$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	-1.0	$\mu\text{A}$	$V_{DS} = -24\text{V}$ , $V_{GS} = 0\text{V}$
		—	—	-25		$V_{DS} = -24\text{V}$ , $V_{GS} = 0\text{V}$ , $T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	-100	$\text{nA}$	$V_{GS} = -20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{GS} = 20\text{V}$

## P-Channel 30 V (D-S) MOSFET

= 25°C (unless otherwise specified)

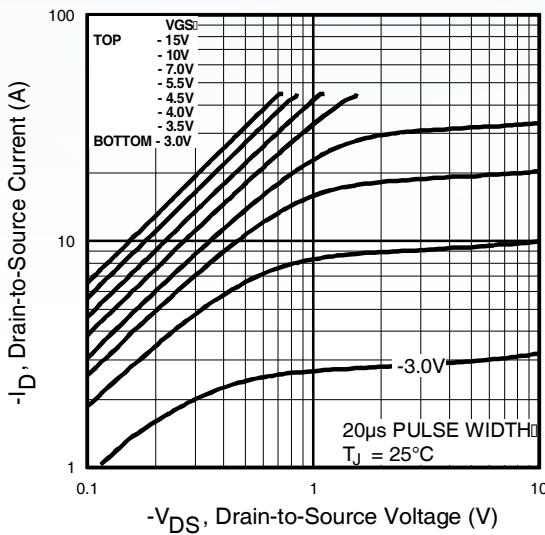
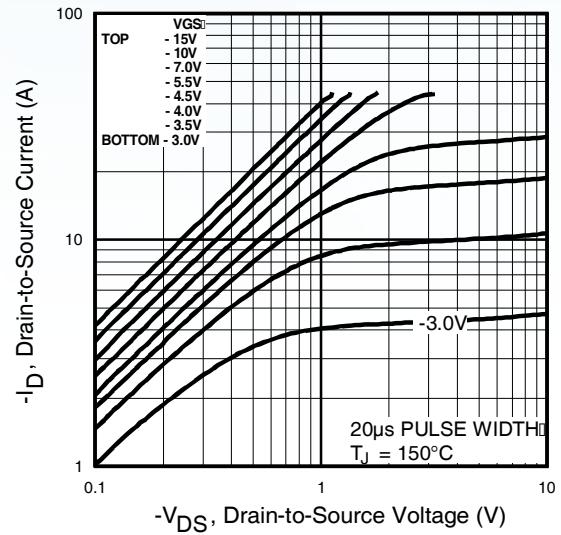
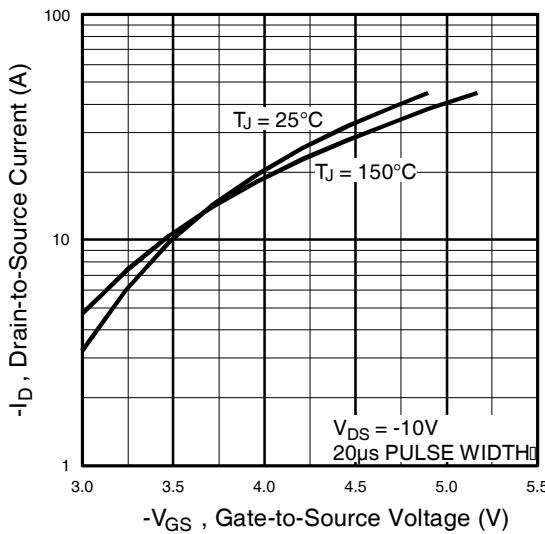
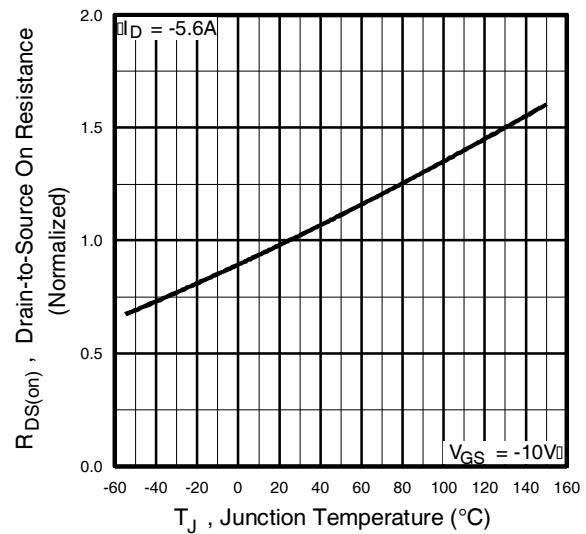
	Parameter	Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge	—	61	92	nC	$I_D = -5.6A$ $V_{DS} = -24V$ $V_{GS} = -10V$ , See Fig. 6 & 9 ④
$Q_{gs}$	Gate-to-Source Charge	—	8.0	12		
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	22	32		
$t_{d(on)}$	Turn-On Delay Time	—	18	—	ns	$V_{DD} = -15V$ $I_D = -5.6A$ $R_G = 6.2\Omega$ $R_D = 2.7\Omega$ , See Fig. 10 ④
$t_r$	Rise Time	—	49	—		
$t_{d(off)}$	Turn-Off Delay Time	—	59	—		
$t_f$	Fall Time	—	60	—	pF	$V_{GS} = 0V$ $V_{DS} = -25V$ $f = 1.0MHz$ , See Fig. 5
$C_{iss}$	Input Capacitance	—	1700	—		
$C_{oss}$	Output Capacitance	—	890	—		
$C_{rss}$	Reverse Transfer Capacitance	—	410	—		

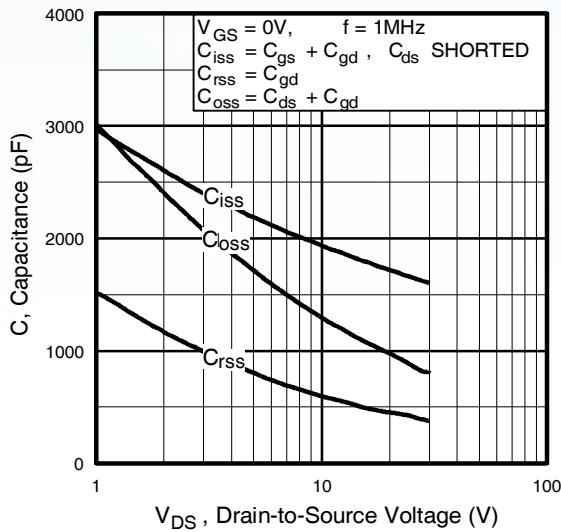
### Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-3.1	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	-45		
$V_{SD}$	Diode Forward Voltage	—	—	-1.0		$T_J = 25^\circ C$ , $I_S = -5.6A$ , $V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time	—	56	85	ns	$T_J = 25^\circ C$ , $I_F = -5.6A$ $di/dt = 100A/\mu s$ ③
$Q_{rr}$	Reverse Recovery Charge	—	99	150	nC	

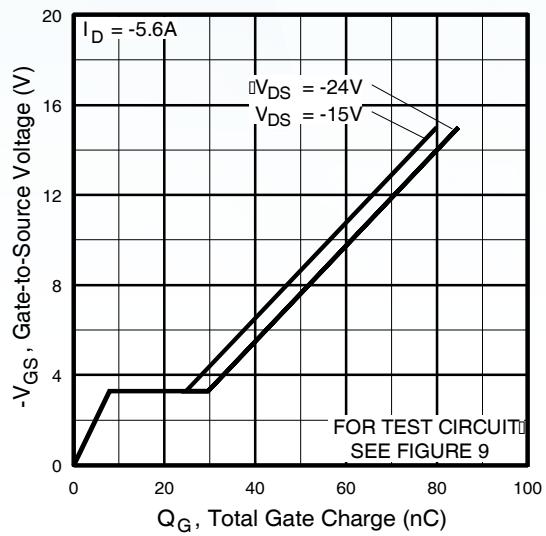
### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ② Starting  $T_J = 25^\circ C$ ,  $L = 25mH$   
 $R_G = 25\Omega$ ,  $I_{AS} = -5.6A$ . (See Figure 12)
- ③  $I_{SD} \leq -5.6A$ ,  $di/dt \leq 100A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 150^\circ C$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .
- ⑤ Surface mounted on FR-4 board,  $t \leq 10sec$ .

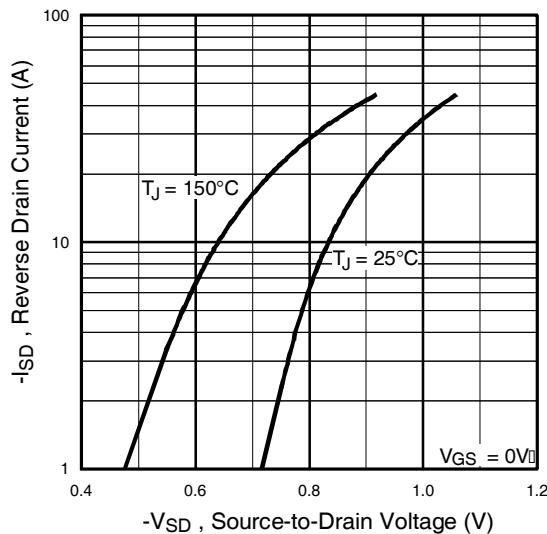
**P-Channel 30 V (D-S) MOSFET**
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Fig 1.** Typical Output Characteristics

**Fig 2.** Typical Output Characteristics

**Fig 3.** Typical Transfer Characteristics

**Fig 4.** Normalized On-Resistance  
Vs. Temperature

**P-Channel 30 V (D-S) MOSFET**
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)


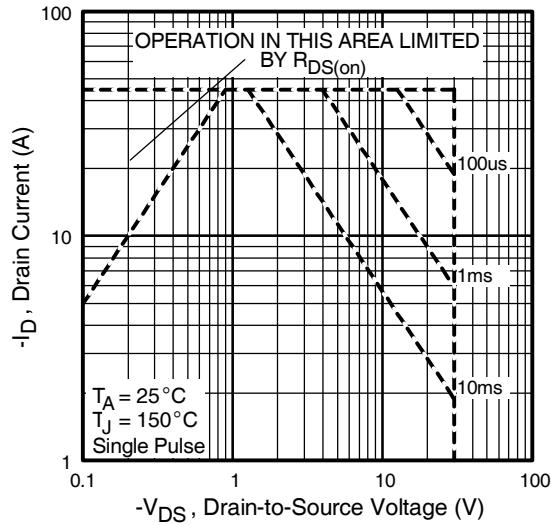
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



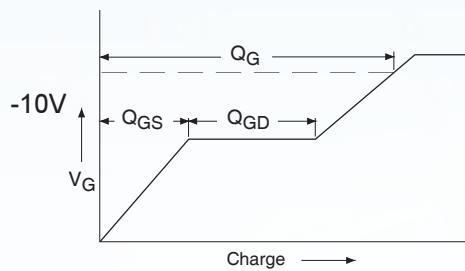
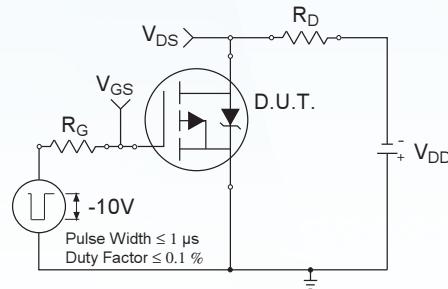
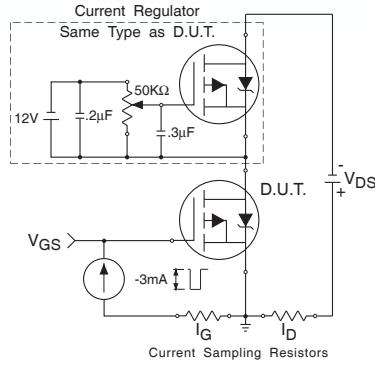
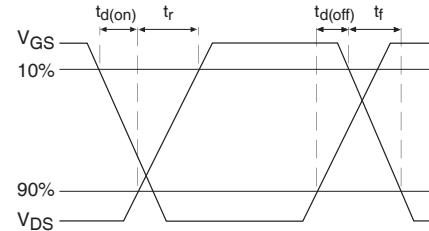
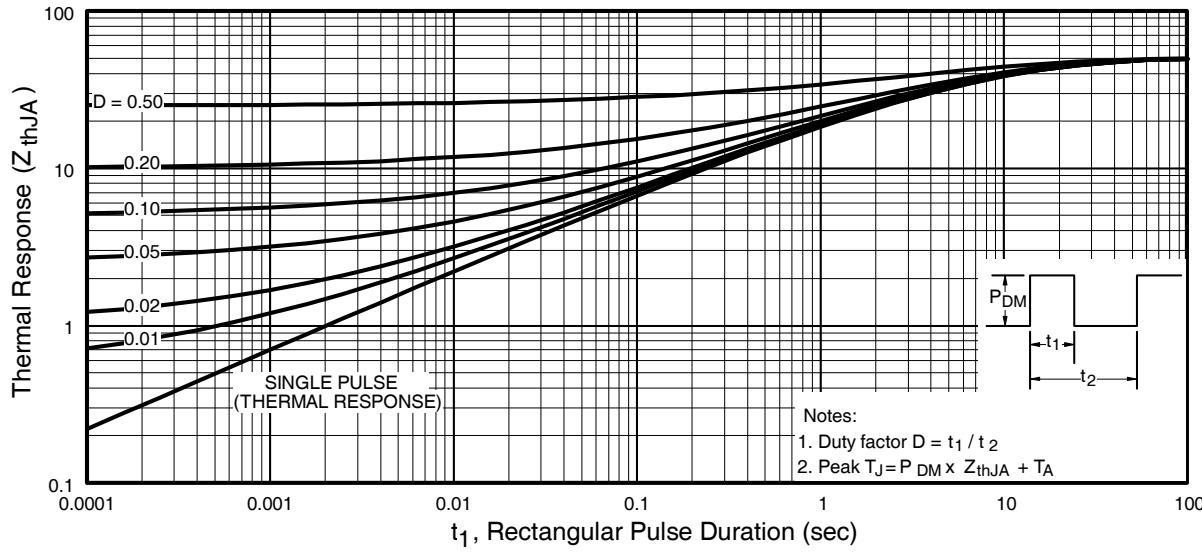
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage

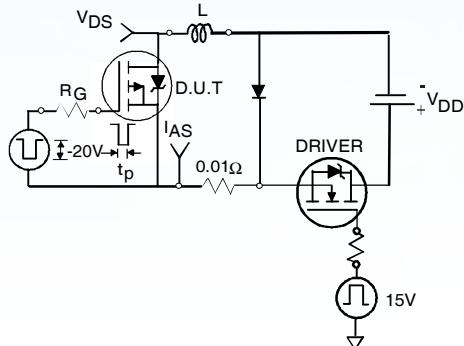
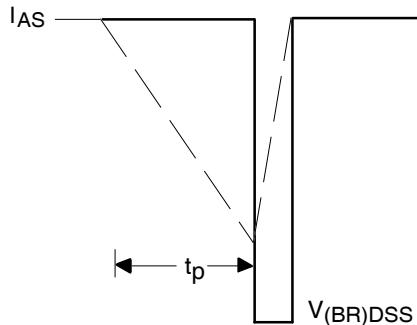
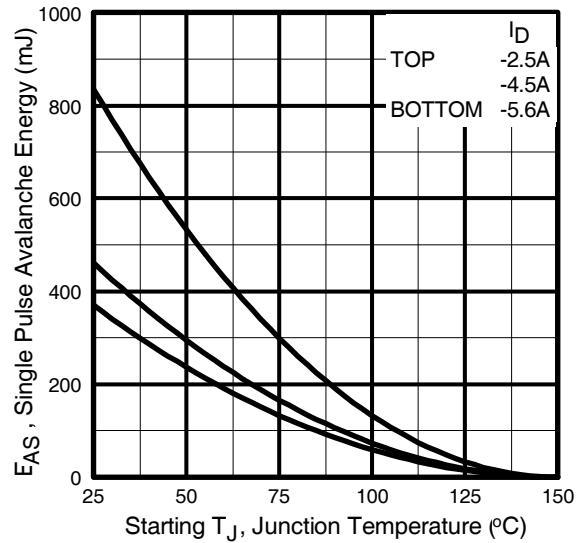


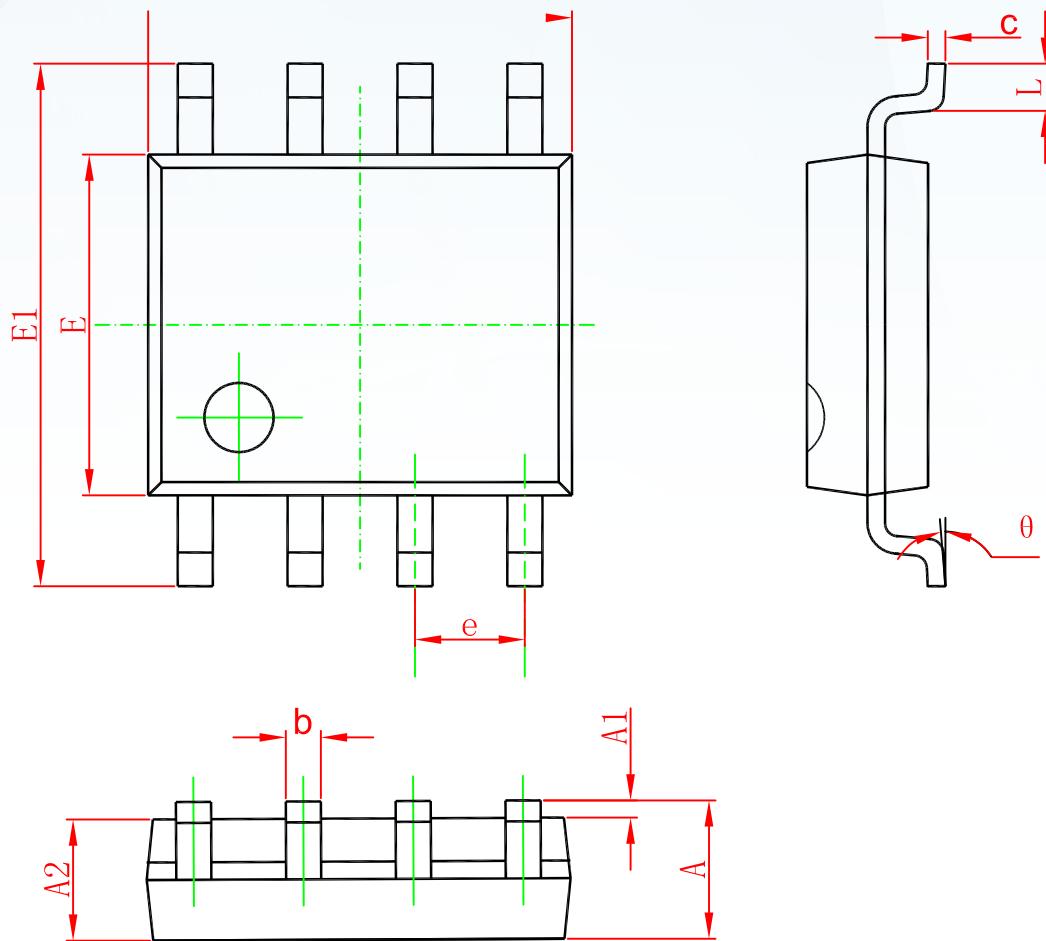
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



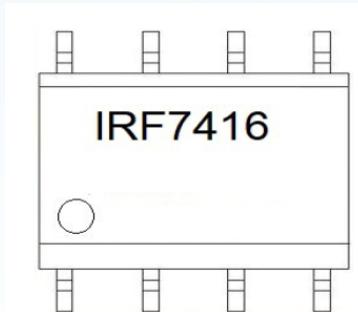
**Fig 8.** Maximum Safe Operating Area

**P-Channel 30 V (D-S) MOSFET**

**Fig 9a.** Basic Gate Charge Waveform

**Fig 10a.** Switching Time Test Circuit

**Fig 9b.** Gate Charge Test Circuit

**Fig 10b.** Switching Time Waveforms

**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

**P-Channel 30 V (D-S) MOSFET**

**Fig 12a.** Unclamped Inductive Test Circuit

**Fig 12b.** Unclamped Inductive Waveforms

**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

**P-Channel 30 V (D-S) MOSFET**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

**P-Channel 30 V (D-S) MOSFET****Ordering information**

Order code	Package	Baseqty	Deliverymode
IRF7416	SOP-8	3000	Tape and reel

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